

# CP3UB17/CP3BT10 External USB Components

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## 1.0 Abstract

The CP3BT10 Connectivity Processor can be made compliant with Revision 2.0 of the USB Specification by means of a few external components. This application note outlines the external circuitry requirements for CP3BT10 based USB devices. This document should be consulted during the schematic design phase for any CP3BT10 based USB device application.

## 2.0 Device Speed Identification

The CP3BT10 is a full speed (12Mb/s) device. High Speed (480Mb/s) functionality and low-speed (1.5Mb/s) functionality are not supported. Full-speed USB devices are identified by upstream host or hub ports by a  $1.5k\Omega \pm 5\%$  pull-up resistor on the D+ line tied to a voltage source between 3.0V and 3.6V. This pull-up resistor is depicted in Figure 1 as  $R_{PU}$ . Figure 7-20 on page 141 of Revision 2.0 of the USB Specification depicts a typical full-speed device cable and resistor connection while section 7.1.5 of the USB Specification describes Device Speed Identification in more detail.

## 3.0 Impedance Matching

Section 7.1.1.1 of the USB Specification Revision 2.0 states that "When the full-speed driver is not part of a high-speed capable transceiver, the impedance of each of the drivers ( $Z_{DRV}$ ) must be between  $28\Omega$  and  $44\Omega$ ." Section 7.1.1.1 also states that, "For a typical CMOS implementation, the driver impedance will typically be realized by a CMOS driver with an impedance significantly less than this resistance with a discrete series resistor making up the balance."

This series resistance is represented in Figure 1 as  $R_S$ . The optimal value of  $R_S$  for the CP3BT10 that provides the fastest D+ and D- rise and fall times while limiting reflections on the USB cable is  $18\Omega$ . However, any value in the range of  $18\Omega$  to  $24\Omega$  will suffice.

## 4.0 Voltage Protection Diodes

Section 7.1.1 of Revision 2.0 of the USB Specification states that, "A USB transceiver is required to withstand a continuous short circuit of D+ and/or D- to  $V_{BUS}$ , GND, other data line, or the cable shield at the connector."

What this means is that if your USB cable gets slammed in a door, nothing upstream or downstream should become damaged.

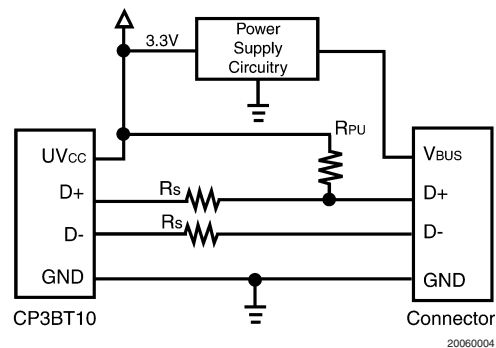
In order to meet this part of the USB Specification, and because the gate oxide on the transceiver driver transistors is only reliable up to 4.2V, external voltage protection diodes should be used. These diodes are depicted as D1 and D2 in Figure 1.

When these external voltage protection diodes are used,  $R_S$  will be required to dissipate a large amount of power if a short occurs. As such,  $1/4$  W, 1206 size, SMD resistors are recommended for  $R_S$ .

## 5.0 Bus-Powered Device

### 5.1 Typical Interface Circuitry

Figure 1 depicts a typical interface for a CP3BT10 based bus-powered USB device.



Refer to Table 1 for component values and part numbers.

FIGURE 1. Bus-Powered Device

### 5.2 $V_{BUS}$ Regulation

In a bus powered device, a buck converter (switching regulator) or a linear regulator can be used to regulate  $V_{BUS}$  to provide power to the USB device. The regulator is required to operate from a minimum of 4.40V, 100 mA of power supplied via  $V_{BUS}$  (see section 7.2 of the USB Specification Revision 2.0).

## 6.0 $V_{BUS}$ Sensing Circuitry

Section 7.1.5.1 of the USB Specification Revision 2.0 states that, "The voltage source on the pull-up resistor must be derived from or controlled by the power supplied on the USB cable such that when  $V_{BUS}$  is removed, the pull-up resistor does not supply current on the data line to which it is attached."

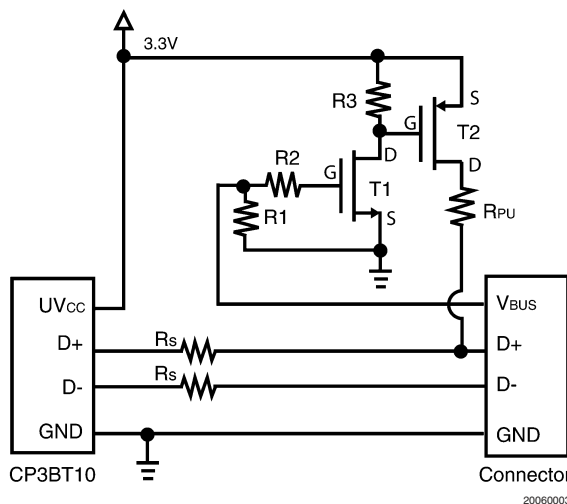
Compliance with this section of the specification is enforced by way of a test for back-voltage on D+ and D-. Section H of the USB-IF Full and Low Speed Electrical and Interoperability Compliance Test Procedure document outlines back-voltage testing. No more than 400mV may be present on either data line before a connection event or after a disconnect event.

The  $V_{BUS}$  Sensing circuitry required for CP3BT10 based self-powered USB device compliance is depicted in Figure 2.  $V_{BUS}$  Sensing circuitry is not required for bus-powered devices.

## 7.0 Self Powered Device

### 7.1 Typical Interface Circuitry

Figure 2 depicts a typical interface for a CP3BT10 based self-powered USB device.



Refer to Table 1 for component values and part numbers.

FIGURE 2. Self-Powered Device

### 7.2 V<sub>BUS</sub> Sensing Current Consumption

Section 7.2.3 of Revision 2.0 of the USB Specification states that, "All USB devices initially default to low-power. Low-power devices or high-power devices operating at low-power are limited to 500  $\mu$ A of suspend current."

The V<sub>BUS</sub> Sensing circuitry depicted in Figure 2 will consume a maximum of  $5.25V/240k\Omega = 21.9 \mu A$  from V<sub>BUS</sub>. This is well within the 500  $\mu$ A maximum value.

## 8.0 Components

Table 1 lists the components found in Figure 1 and Figure 2.

TABLE 1. Components

| Designator      | Description                        | Value                    |
|-----------------|------------------------------------|--------------------------|
| R <sub>S</sub>  | Impedance Matching Series Resistor | 18 $\Omega$ , 1206, 1/4W |
| R <sub>PU</sub> | Pull-Up Resistor                   | 1.5k $\Omega$            |
| D1              | Voltage Protection Diode           | B0520LW                  |
| D2              | Voltage Protection Diode           | B0520LW                  |
| R1              | Biasing Resistor                   | 240k $\Omega$            |
| R2              | MOSFET Gate Protection Resistor    | 10k $\Omega$             |
| R3              | Biasing Resistor                   | 240k $\Omega$            |
| T1              | N-Channel MOSFET                   | MMBF170                  |
| T2              | P-Channel MOSFET                   | BSS84                    |

**Notes**

## Notes

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